

Notice of References Cited	Application/Control No. 10/564,428		Applicant(s)/Patent Under Reexamination ECOFF ET AL.	
	Examiner M. Lee		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,428,022	09-2008	Teichner et al.	348/725
*	B	US-5,557,617	09-1996	Belcher et al.	370/316
*	C	US-5,926,228	07-1999	Jeon et al.	348/554
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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